EQDP-ESE-7 Rev. 3 6/81

EQUIPMENT QUALIFICATION DATA PACKAGE

This document contains information, relative to the qualification of the equipment identified below, in accordance with the methodology of WCAP 8587. The Specification section (Section 1) defines the assumed limits for the equipment qualification and constitute interface requirements to the user.

Resistance Temperature Detectors: Fast Response Well Mounted

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SECTION 1 - SPECIFICATIONS

1.0 PERFORMANCE SPECIFICATIONS

1.1 Electrical Requirements

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1.1.1	Voltage: (Ref. 1.3 Auxiliary Devices with
	approximately 1 milliamp current)
1.1.2	Frequency: N/A
1.1.3	Load: N/A
1.1.4	Electromagnetic Interference: None
1.1.5	Other: Resistance 410 Ω at 525°F

1.2 Installation Requirements: M Drawing 1683C01

- 1.3 Auxiliary Devices: Thermowell, R/E or R/I Converter and the RTD requires an interface connection which will be subject to the same conditions as the RTD. The qualification of these interface connections is not an objective of this program
- 1.4 Preventative Maintenance Schedule: None
- 1.5 Design Life: 40 years
- 1.6 Operating Cycles (Expected number of cycles during design life, including test): Continuous duty

1.7 Performance Requirements for^(b): T_C - Narrow Range

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		Normal	Abnormal	Containment Test	DB	E Conditions(a)		Post (OBE Conditions	(a)
	Parameter	Conditions	Conditions	Conditions	FLB/LOCA	<u>SI.B</u>	Seismic	FLB/LOCA	<u>SLB</u>	Seismic
1.7.1	Time requirement	Continuous	Included under normal	Test duration	N/A	< 5 mins	Event duration	N/A	N/A	Continuous
1.7.2	Performance requirement	(C)		No damage		As normal	As normal			As normal
1.8 Environ	mental Conditions	for Same Fun	ction							
1.8.1	Temperature(^O F) Nominal Ar Maximum Ar	nbient 122		Ambient		Fig. 1	Ambient			Ambient
8.2	Pressure (psig)	-0.1 to .3 3125 (well)		70		Fig. 1	0			0
1.8.3	Humidity (percent RH)	95		Ambient		100	Ambient			Ambient
1.8.4	Radiation (R)	1.4x10 ⁸ y (1 8x10 ⁶ y(cab)			None	10^{7} y(tip) ^(e) < 10^{4} y(cable) < 10^{5} g(cable)	None			None
1.0.5	Chemicals	None				Fig. 1	None			None
1.8.5		None				None	None			None
1.8.6	Vibration	See Sec- tion 2.10				None	None			
1.8.7	Acceleration (g)) None				None	Fig. 2			None
Notes: a: b:	DBE is the Design Margin is not in of this section	ncluded in th	t. e parameters		seco a wa 20 y	2°F repeatability nds w/we'l for st ter flow of 50 ft ear life assumed nal rating dose. cained accident	ep change of /sec.	at least 20%	with	uid defines

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1.9 Qualified Life: 20 years at 122°F
11.8 years at 140°F

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1.10 Remarks: None









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SECTION 2 - QUALIFICATION BY TEST

2.0 TEST PLAN

- 2.1 Equipment Description: RdF Fast response well mounted thermowell mounted resistance temperature detectors
- 2.2 Number Tested: Lot test performed on four (4) units
- 2.3 Mounting: Per Section 1.2
- 2.4 Connections: 4-wire cable to R/E converter
- 2.5 Aging Simulation Procedure:

Sequential simulation of thermal, radiation and vibration mechanisms as part of the overall test sequence.

2.7.5 Calegory V - Electrical Characteristics

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2.7.5.1	Insulation Resistance	A, B, C
2.7.5.2	Output Voltage	A,B,C
2.7.5.3	Output Current	A,B,C
2.7.5.4	Output Power	A,B,C
2.7.5.5	Response Time	A,B,C
2.7.5.6	Frequency Characteristics	A,B,C
2.7.5.7	Simulated Load	A,B,C

2.7.6 Category VI - Mechanical Characteristics

2.7.6.1	Thrust	A, B, C
2.7.6.2	Torque	A,B,C
2.7.6.3	Time	A,B,C
2.7.6.4	Load Profile	A, B, C

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Function	and Requi	í _d	
rements)			
		Function and Requi	ory VII - Auxiliary Equipment Function and Required rements)

2.7.7.1	R/E Converter Voltage	A, B, C
	(RTD analog out)	

A: HELB Test B: Seismic Test C: Radiation Test

2.8 Test Sequence Preferred

This section identifies the test sequences as specified in IEEE-323-1974

- 2.8.1 Inspection of Test Item
- 2.8.2 Operation (Normal Condition)
- 2.8.3 Operation (Performance Specifications Extremes, Section 1)
- 2.8.4 Simulated Aging
- 2.8.5 Vibration
- 2.8.6 Operation (Simulated High Energy Line Break Conditions)
- 2.8.7 Operation (Simulated Fost HELB Conditions)
- 2.8.8 Inspection

2.9 Test Sequence Actual

This section identifies the actual test sequence which constitutes the qualification program for this equipment. A justification for anything other than the preferred sequence is provided. The normal operation test condition referred to is a static calibration check at 32°F, 525°F and 625°F. Time response testing has been successfully performed via type testing on a sample model of this RTD Performance under abnormal operating conditions is covered under Sections 2.8.2 and 2.8.6. Westinghouse has identified no mechanisms that would cause a degradation in time response and not affect RTD calibration. Therefore, the calibration data taken during the test is adequate to monitor the performance of the RTD for both conditions. Since the probe materials are not sensitive to thermal degradation, time response testing has been excluded from the test sequence.

Test Sequence (from Section 2.8):

- 2.8.1 Inspection
- 2.8.2 Operation-Normal Condition (Static Calibration)
- 2.8.4 Thermal Aging, Thermal Cycling
- 2.8.2 Static Calibration
- 2.8.4 Radiation, Normal and Post-Accident

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2.8.2 Static Calibration

2.8.4 Environmental Vibration Induced Aging

2.8.5 Operating Basis Earthquake, Safe Shutdown Earthquakes

2.8.2 Static Calibration

2.8.6 High Energy Line Break Simulation

2.8.7 Post HELB Simulation

2.8.2 Static Calibration

2.8.8 Inspection

2.10 Type Test Data

2.10.1 Objective

The objective of this test program is to demonstrate, employing the recommended practices of Reg. Guide 1.89 (IEEE 323-1974) and Reg. Guide 1.100 (IEEE 344-1975), the capability of the fast response resistance temperature detectors to complete their safety related functions described in EQDP Section 1.7 while exposed to the applicable environments defined in EODP Section 1.8.

2.10.2 Equipment Tested

Four RdF thermowell mounted fast response resistance temperature detectors were subjected to the test environments of the sequence shown in Section 2.9.

2.10.3 Test Summary

2.10.3.1 Normal Environment Testing

Operation of the fast response RTD's under normal conditions is reflected by the numerous threetemperature static calibrations performed between each phase of the test sequence reported in reference 1.

2.10.3.2 Simulated Aging

The test units were pre-conditioned to a simulated twenty year aged condition prior to subjecting them to the design basis seismic event and high energy line break simulation. The aged condition was achieved by separate phases of accelerated thermal aging, thermal cycling, radiation exposure to a total integrated gamma dose equivalent to a twenty-year normal dose plus the design basis accident dose, and accelerated flow induced and pipe vibration simulation. Through all the preconditioning phases, the amplified RTD outputs were monitored to verify continuous operation.

2.10.3.3 Seismic Tests

The single design basis event capable of producing an adverse environment at the equipment location is a seismic event. The seismic testing reported in Reference 1 was completed on aged equipment employing many multi-axis, single-frequency inputs in accordance with Reg. Guide 1.100 (IEEE 344-1975). The generic required input motion (Figure 2) contains significant margin with respect to any single plant application referencing this program(1). Each plant should compare this input motion to assure that a 10 percent margin exists based on their actual plant location.

2.10.3.4 High Energy Line Break/Post HELB Simulation

The fast response RTD's were subjected to the HELB simulation temperature profile of Figure 3. Following the 420°F temperature peak, the temperature

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gradually declines to 250°F and is held at saturated steam conditions for 15 days, simulating a four-month period of post HELB operation. This post-accident aging simulation was performed but not required for this application.

2.10.4 Conclusion

The qualification status of the Fast Response Well Mounted RTD's is demonstrated by the completion of the simulated aging and design basis condition testing described herein and reported in Reference 1.

- 2.11 The generic tests completed by Westinghouse employ parameters designed to envelope a number of plant applications. Margin is a plant specific parameter and will be established by the applicant.
- 2.12 References
 - Skeers, D.M., Rens, T.E., "Equipment Qualification Report, Resistance Temperature Dotectors - Fast Response Well Mounted (Seismic and Environmental Testing)" WCAP-8687, Supplement 2-E07A (Proprietary), WCAP-8587, Supplement 2-E07A (Non-Proprietary), March, 1981.

SECTIONS 3 AND 4 QUALIFICATION BY EXPERIENCE AND/OR ANALYSIS

Westinghouse does not employ operating experience or analysis in support of the qualification program for the Fast Response Well Mounted RTD's.